## Notice of References Cited Application/Control No. 10/642,945 Examiner Kien T. Nguyen Applicant(s)/Patent Under Reexamination KRYSIAK ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2,945,693	07-1960	WAY JACK W	473/605
*	В	US-5,096,756	03-1992	Walters, Peter J.	428/35.5
*	С	US-5,098,097	03-1992	Kennedy et al.	473/599
*	D	US-5,636,835	06-1997	Schindler et al.	473/605
*	Е	US-5,669,838	09-1997	Kennedy et al.	473/596
*	F	US-5,681,233	10-1997	Guenther et al.	473/605
*	G	US-5,580,049	12-1996	Brantley, Derrick K.	473/599
*	H	US-6,024,661	02-2000	Guenther et al.	473/605
*	_	US-6,123,633	09-2000	Guenther et al.	473/604
*	7	US-6,206,794	03-2001	Chan, Chong Veng	473/599
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Р					
	Q					
	R					
	S			1		
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.